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## Contents – Volume XIII

<b>18</b>	<b>Visualization of Epicuticular Grease on the Covering Wings in the Colorado Potato Beetle: A Scanning Probe Approach</b>	
	<i>D. Voigt, H. Peisker, S. Gorb</i> .....	1
18.1	Introduction .....	2
18.1.1	Epicuticular Grease: Introductory Remarks .....	2
18.1.2	Covering Wings and Mating Behaviour .....	3
18.2	Methods .....	4
18.2.1	Insects and Sample Preparation .....	4
18.2.2	Scanning Probe Microscopy .....	5
18.2.3	Cryo-SEM .....	6
18.3	Results .....	7
18.3.1	Elytra Topography and Grease Visualization .....	7
18.3.2	Adhesive Properties of the Elytra Surface .....	9
18.4	Discussion .....	10
18.5	Conclusions .....	13
	References .....	13
<b>19</b>	<b>A Review on the Structure and Mechanical Properties of Mollusk Shells – Perspectives on Synthetic Biomimetic Materials</b>	
	<i>Francois Barthelat, Jee E. Rim, Horacio D. Espinosa*</i> .....	17
19.1	Introduction .....	17
19.1.1	Mollusk Shells: Overview .....	18
19.2	Cross-Laminar Shells: The Pink or Queen Conch ( <i>Strombus gigas</i> ) ..	19
19.2.1	Structure .....	19
19.2.2	Mechanisms of Toughening .....	21
19.3	Nacreous Shells .....	24
19.3.1	Overview of Nacre .....	26
19.3.2	Structure .....	26
19.3.3	The Deformation of Nacre .....	27

19.3.4	The Fracture of Nacre . . . . .	32
19.4	Artificial Shell Materials . . . . .	34
19.4.1	Large-Scale “Model Materials” . . . . .	34
19.4.2	Ice Templatation . . . . .	36
19.4.3	Layer-by-Layer Deposition . . . . .	38
19.4.4	Thin Film Deposition: MEMS-Based Structure . . . . .	39
19.5	Conclusions . . . . .	41
	References . . . . .	41
<b>20</b>	<b>Electro-Oxidative Lithography and Self-Assembly Concepts for Bottom-Up Nanofabrication</b>	
	<i>Stephanie Hoeppener, Ulrich S. Schubert . . . . .</i>	45
20.1	Introduction . . . . .	45
20.2	Chemically Active Surface Templates . . . . .	46
20.2.1	Locally Confined Self-Assembled Monolayers . . . . .	46
20.2.2	Electrical Structuring Techniques of SAMs . . . . .	48
20.3	Conclusions . . . . .	66
	References . . . . .	67
<b>21</b>	<b>Application of SPM and Related Techniques to the Mechanical Properties of Biotoool Materials</b>	
	<i>Thomas Schöberl, Ingomar L. Jäger, Helga C. Lichtenegger . . . . .</i>	71
21.1	Introduction . . . . .	72
21.2	Typical Biotoool Materials . . . . .	74
21.2.1	Chemistry . . . . .	74
21.2.2	Structures . . . . .	76
21.2.3	Mechanical Properties . . . . .	78
21.3	Experimental Methods and Setups . . . . .	79
21.3.1	SPM and Indentation . . . . .	79
21.3.2	Scratch and Wear Tests . . . . .	81
21.3.3	Dynamic Modes . . . . .	82
21.3.4	Fracture Toughness Tests . . . . .	83
21.4	Samples . . . . .	84
21.4.1	Choice . . . . .	84
21.4.2	Storage . . . . .	85
21.4.3	Preparation . . . . .	86
21.5	Experimental Conditions . . . . .	87
21.5.1	Moisture . . . . .	87
21.5.2	Temperature . . . . .	88
21.5.3	Probe Tips . . . . .	88

21.5.4	Test Velocity .....	89
21.6	Results .....	89
21.6.1	Sources of Error .....	89
21.6.2	Interpretation .....	94
21.7	Examples from the Literature .....	95
References	.....	98

<b>22</b>	<b>Nanomechanics and Microfluidics as a Tool for Unraveling Blood Clotting Disease</b> <i>D.M. Steppich, S. Thalhammer, A. Wixforth, M.F. Schneider</i> .....	105
22.1	Introduction .....	105
22.2	Topography .....	106
22.2.1	Little Story of Blood Clotting .....	107
22.2.2	High-Resolution Imaging .....	110
22.3	Lab-on-a-Chip .....	117
22.3.1	Nanomechanical Diagnostics .....	118
22.3.2	Mimicking Blood Flow Conditions on a Surface Acoustic Wave-Driven Biochip .....	120
22.4	The Lab on a Chip – AFM – Hybrid .....	122
22.4.1	Experimental Setup .....	122
22.4.2	Bundle Relaxation .....	124
22.4.3	Stream Line Manipulation and Flow Sensoring .....	128
22.5	Summary and Outlook .....	132
References	.....	133

<b>23</b>	<b>Atomic Force Microscopic Study of Piezoelectric Polymers</b> <i>Hyungoo Lee · Ke Wang · Taekwon Jee · Hong Liang</i> .....	137
23.1	Piezoelectric Materials .....	137
23.2	Atomic Force Microscopy .....	138
23.3	Atomic Force Microscope Measurement .....	139
23.3.1	Sample Materials .....	141
23.3.2	Surface Image Analysis .....	141
23.3.3	Surface Force Measurements .....	143
23.3.4	Nano-Piezoelectricity .....	146
23.3.5	Conductivity Measurement of PVDF Samples .....	149
23.3.6	Time-Dependent Study .....	149
References	.....	152

<b>24</b>	<b>Quantitative Analysis of Surface Morphology and Applications</b>	
	<i>Maria Cecília Salvadori</i> . . . . .	153
24.1	Introduction . . . . .	153
24.2	Quantifying Morphology . . . . .	154
24.3	Applications of Quantitative Morphological Surface Analysis . . . . .	157
24.3.1	Dynamic Growth of Thin Films . . . . .	157
24.3.2	Periodicity Analysis of Lines Nanolithographed by AFM in PMMA . . . . .	161
24.3.3	Electrical Resistivity of Nanostructured Thin Films . . . . .	167
24.3.4	Morphological and Crystallographic Grain Sizes . . . . .	173
24.4	Final Remarks . . . . .	178
	References . . . . .	178
<b>25</b>	<b>Nanotribological Characterization of Carbonaceous Materials: Study of Diamond Coatings and Graphite</b>	
	<i>Marjorie Schmitt, Sophie Bistac</i> . . . . .	181
25.1	Introduction . . . . .	182
25.2	Nanotribology of Carbonaceous Materials: State of the Art . . . . .	182
25.2.1	Role of the Scanning Velocity . . . . .	185
25.2.2	Role of the Environment . . . . .	185
25.2.3	Role of the Contact Load . . . . .	186
25.2.4	Role of the Chemistry . . . . .	187
25.2.5	Role of the Chemistry – Bulk Chemistry . . . . .	187
25.2.6	Role of the Chemistry—Superficial Chemistry . . . . .	188
25.3	Experimental Details . . . . .	188
25.3.1	Diamond Coatings: The Flame Process . . . . .	188
25.3.2	Graphite Pins . . . . .	189
25.3.3	Atomic Force Microscopy . . . . .	189
25.3.4	Tribometer for Macroscopic Tests . . . . .	190
25.3.5	Modification of the Superficial Energy of Silicon Wafers . . . . .	190
25.4	Nanofriction Results . . . . .	191
25.4.1	Diamond Coatings (Obtained by Flame Process) . . . . .	191
25.4.2	Graphite . . . . .	194
25.5	Conclusions . . . . .	200
	References . . . . .	201
<b>26</b>	<b>Atomic Force Microscopy Studies of Aging Mechanisms in Lithium-Ion Batteries</b>	
	<i>Shrikant C. Nagpure, Bharat Bhushan</i> . . . . .	203
26.1	Introduction . . . . .	203
26.1.1	Battery Types . . . . .	206

---

26.2	Lithium-Ion Batteries . . . . .	212
26.2.1	Electrochemistry of Lithium-Ion Batteries . . . . .	212
26.2.2	Different Shapes of Lithium-Ion Batteries . . . . .	213
26.2.3	Types of Lithium-Ion Batteries . . . . .	214
26.2.4	Requirements in Modern Lithium-Ion Batteries . . . . .	217
26.3	Aging of Lithium-Ion Batteries . . . . .	217
26.3.1	Anode . . . . .	218
26.3.2	Cathode . . . . .	224
26.4	Closure . . . . .	230
	References . . . . .	231
	<b>Subject Index</b> . . . . .	235



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# Contents – Volume XI

<b>1</b>	<b>Oscillation Control in Dynamic SPM with Quartz Sensors</b>	
	<i>Johann Jersch, Harald Fuchs</i> . . . . .	1
1.1	Introduction . . . . .	1
1.2	Definition and Measurement of Signal Parameters . . . . .	3
1.3	Connection Between Oscillation Parameters and Tip–Sample Interactions . . . . .	7
1.4	Oscillation Control for QCR, Technical Realization . . . . .	8
1.5	Applications of the Oscillation Controllers . . . . .	12
1.6	Summary . . . . .	13
	References . . . . .	14
<b>2</b>	<b>Atomic Force Microscope Cantilevers Used as Sensors for Monitoring Microdrop Evaporation</b>	
	<i>Elmar Bonaccorso, Dmytro S. Golovko, Paolo Bonanno, Roberto Raiteri, Thomas Haschke, Wolfgang Wiechert, Hans-Jürgen Butt</i> . . .	17
2.1	Introduction . . . . .	18
2.2	Background, Materials and Methods . . . . .	19
2.2.1	Drop in Equilibrium . . . . .	19
2.2.2	Evaporating Drop . . . . .	21
2.2.3	Experimental Setup . . . . .	22
2.3	Evaporation Results on Microdrops . . . . .	24
2.3.1	Evaporation Curve . . . . .	24
2.3.2	Force Model . . . . .	24
2.3.3	Negative Inclination . . . . .	26
2.3.4	Mass and Inclination . . . . .	28
2.3.5	Vaporization Heat . . . . .	30
2.4	Further Applications of Drops on Cantilevers . . . . .	31
2.4.1	Spring Constant Calibration . . . . .	31
2.4.2	Contamination Control of Cantilevers . . . . .	33

2.5	Conclusions .....	36
	References .....	36
<b>3</b>	<b>Mechanical Diode-Based Ultrasonic Atomic Force Microscopies</b>	
	<i>M. Teresa Cuberes</i> .....	39
3.1	Introduction: Acoustic Microscopy in the Near Field .....	39
3.1.1	Acoustic Microscopy: Possibilities and Limitations .....	39
3.1.2	Ultrasonic Atomic Force Microscopies .....	41
3.2	Ultrasonic Force Microscopy: The Mechanical Diode Effect .....	44
3.2.1	The Mechanical Diode Effect .....	44
3.2.2	Experimental Implementation of UFM .....	46
3.2.3	Information from UFM Data .....	47
3.2.4	Applications of UFM in Nanofabrication .....	52
3.3	Mechanical Diode Ultrasonic Friction Force Microscopy .....	54
3.3.1	The Lateral Mechanical Diode Effect .....	54
3.3.2	Experimental Implementation of MD-UFFM .....	56
3.3.3	Comparison of MD-UFFM with UFFM and TRmode AFM .....	56
3.3.4	Information from MD-UFFM Data .....	58
3.4	Heterodyne Force Microscopy: Beats at Nanocontacts .....	62
3.4.1	Beats at Nanocontacts .....	62
3.4.2	Experimental Implementation of HFM .....	64
3.4.3	Comparison of HFM with UFM .....	65
3.4.4	Information from HFM: Time Resolution .....	66
	References .....	68
<b>4</b>	<b>Contact Atomic Force Microscopy: A Powerful Tool in Adhesion Science</b>	
	<i>Maurice Brogly, Houssein Awada, Olivier Noel</i> .....	73
4.1	Introduction .....	73
4.2	Adhesion Science .....	74
4.2.1	Adhesion and Adhesive Strength .....	74
4.2.2	Adhesion at a Local Scale .....	75
4.3	Force vs. Distance Measurements with an AFM .....	76
4.4	AFM Calibration .....	77
4.4.1	Selection of Tips .....	77
4.4.2	Determination of the Spring Constant of the Cantilever .....	78
4.4.3	Determination of the Tip Radius .....	78
4.4.4	Nonlinearity of the Quadrant of Photodiodes .....	79
4.4.5	Scan Rate of the Cantilever .....	79
4.4.6	Systematic Check .....	79
4.4.7	Estimation of the Uncertainties Related to the Experimental Pull-Off Force Measurements .....	79



4.5	Adhesion Forces and Surface Energies . . . . .	80
4.5.1	Materials . . . . .	80
4.5.2	Preparation of Oxidized Silica Surface . . . . .	80
4.5.3	Grafting of Functionalized SAMs on Silicon Wafer . . . . .	81
4.5.4	Characterization of the SAMs . . . . .	81
4.5.5	Force-Distance Curves on Rigid Systems Having Controlled Surface Chemistry . . . . .	82
4.5.6	Influence of Capillary Forces on Adhesion Forces . . . . .	84
4.6	Adhesion Forces Measurements on Polymers . . . . .	85
4.6.1	Cross-Linking and Functionalization of PDMS Networks . . . . .	85
4.6.2	Force-Distance Curves on Soft Polymer Surfaces . . . . .	86
4.6.3	Real Indentation of the AFM Tip Inside a Soft Polymer . . . . .	88
4.7	AFM Nano-Indentation Experiments on Polymer Networks . . . . .	89
4.7.1	Force-Indentation Curves . . . . .	89
4.7.2	Nano-Indentation and Nano-Adhesion on Soft Polymers Having Controlled Surface Chemistry and Mechanical Properties . . . . .	91
4.8	Conclusion . . . . .	94
	References . . . . .	94

<b>5</b>	<b>Contact Resonance Force Microscopy Techniques for Nanomechanical Measurements</b> <i>Donna C. Hurley</i> . . . . .	97
5.1	Introduction . . . . .	99
5.2	Cantilevers for Contact Resonance Force Microscopy . . . . .	101
5.3	Data Acquisition Techniques . . . . .	103
5.4	Data Analysis Methods . . . . .	107
5.4.1	Model for Cantilever Dynamics . . . . .	107
5.4.2	Model for Contact Mechanics . . . . .	111
5.5	Survey of Contact Resonance Force Microscopy Measurements . . .	113
5.6	Theoretical Principles for Optimizing Experiments . . . . .	116
5.6.1	Cantilever Dynamics: Which Modes? . . . . .	116
5.6.2	Contact Mechanics: What Forces? . . . . .	119
5.6.3	An Example . . . . .	121
5.7	Practical Issues for Optimizing Experiments . . . . .	122
5.7.1	Exciting and Detecting the Cantilever's Resonant Modes . . . . .	122
5.7.2	Tip Shape and Tip Wear . . . . .	124
5.8	Imaging with Contact Resonance Force Microscopy . . . . .	127
5.9	The Road Ahead . . . . .	132
	References . . . . .	135

<b>6</b>	<b>AFM Nanoindentation Method: Geometrical Effects of the Indenter Tip</b>	
	<i>Lorenzo Calabri, Nicola Pugno, Sergio Valeri</i> . . . . .	139
6.1	Introduction . . . . .	139
6.2	Experimental Configuration . . . . .	144
6.2.1	FIB Nanofabrication . . . . .	145
6.2.2	Tip Radius of Curvature Characterization . . . . .	148
6.2.3	Nanoindentation Experimental Setup . . . . .	149
6.3	Numerical Model . . . . .	150
6.4	Theoretical Model: A Shape/Size-Effect Law for Nanoindentation . . . . .	151
6.5	Deconvolution of the Indentation Impressions . . . . .	157
6.6	Results . . . . .	157
6.7	Conclusion . . . . .	162
	References . . . . .	163
<b>7</b>	<b>Local Mechanical Properties by Atomic Force Microscopy Nanoindentations</b>	
	<i>Davide Tranchida, Stefano Piccarolo</i> . . . . .	165
7.1	Introduction . . . . .	166
7.2	The Scale of AFM Nanoindentations . . . . .	169
7.3	The Relationship with Microhardness and Analysis of the Unloading Curve . . . . .	173
7.4	Models to Describe the Force Curves . . . . .	178
7.5	Final Remarks on Loading History, Adhesion, Roughness Effects . . . . .	187
7.6	Selected Applications . . . . .	190
	References . . . . .	195
<b>8</b>	<b>Thermal Activation Effects in Dynamic Force Spectroscopy and Atomic Friction</b>	
	<i>Mykhaylo Evstigneev</i> . . . . .	199
8.1	Introduction . . . . .	200
8.1.1	Determination of Bond Strength of Biological Complexes . . . . .	201
8.1.2	Atomic Friction . . . . .	202
8.2	Standard Method of Data Analysis . . . . .	204
8.2.1	Rate Equation Approach . . . . .	204
8.2.2	Most Probable Rupture Force . . . . .	206
8.2.3	DFS Pulling Experiments: Mean Rupture Force . . . . .	209
8.2.4	Atomic Friction: Average Force in the Stick-Slip Regime . . . . .	210
8.3	Alternative Method of Data Analysis . . . . .	213

---

8.4	Application to DFS Pulling Experiments . . . . .	216
8.5	Application to Atomic Friction . . . . .	219
8.6	Conclusions . . . . .	225
	References . . . . .	226
	<b>Subject Index</b> . . . . .	231



---

## Contents – Volume XII

<b>9</b>	<b>Direct Force Measurements of Receptor–Ligand Interactions on Living Cells</b>	
	<i>Robert H. Eibl</i> .....	1
9.1	Introduction .....	2
9.2	Procedure .....	8
9.2.1	Principle of AFM Force Spectroscopy .....	9
9.2.2	Cell–Cell Interactions .....	9
9.2.3	Cell–Substrate Measurements .....	12
9.2.4	Specificity and Blocking Antibodies .....	14
9.2.5	Activation by SDF-1 .....	17
9.3	Protocols .....	20
9.3.1	Cantilever Functionalization .....	20
9.3.2	AFM Measurement on Living Cells .....	22
9.3.3	Inhibition with Blocking Antibodies, Peptidomimetic Inhibitors or EDTA .....	25
9.3.4	Activation with $Mg^{2+}$ , $Mn^{2+}$ Ions, Activating Antibodies, Phorbol ester or Chemokines .....	26
9.3.5	AFM Measurement—Cell Free .....	26
9.4	Conclusion and Future Developments .....	27
	References .....	29
<b>10</b>	<b>Imaging Chemical Groups and Molecular Recognition Sites on Live Cells Using AFM</b>	
	<i>David Alsteens, Vincent Dupres, Etienne Dague, Claire Verbelen, Guillaume André, Grégory Francius, Yves F. Dufrêne</i> .....	33
10.1	Introduction .....	33
10.2	Chemical Force Microscopy .....	34
10.2.1	Methods .....	34
10.2.2	Probing Hydrophobic Forces .....	35
10.2.3	Chemical Force Microscopy of Live Cells .....	38
10.3	Molecular Recognition Imaging .....	42
10.3.1	Spatially Resolved Force Spectroscopy .....	43

10.3.2	Immunogold Imaging . . . . .	45
10.4	Conclusions . . . . .	47
	References . . . . .	47
<b>11</b>	<b>Applications of Scanning Near-Field Optical Microscopy in Life Science</b> <i>Pietro Giuseppe Gucciardi</i> . . . . .	49
11.1	Introduction . . . . .	50
11.2	Experimental Techniques in Near-Field Optical Microscopy . . . . .	51
11.2.1	Principles of Near-Field Optical Microscopy . . . . .	51
11.2.2	Fluorescence Near-Field Optical Microscopy . . . . .	53
11.2.3	Near-Field Optical Microscopy in Liquid . . . . .	55
11.2.4	Tip-Enhanced Near-Field Optical Microscopy . . . . .	57
11.3	Applications of Near-Field Optical Microscopy in Life Science . . . . .	58
11.3.1	Infrared Imaging of Tobacco Mosaic Virus with Nanoscale Resolution . . . . .	58
11.3.2	Co-Localization of Malarial and Host Skeletal Proteins in Infected Erythrocytes by Dual-Color Near-Field Fluorescence Microscopy . . . . .	59
11.3.3	Co-Localization of $\alpha$ -Sarcoglycan and $\beta$ 1D-Integrin in Human Muscle Cells by Near-Field Fluorescence Microscopy . . . . .	61
11.3.4	Single Molecule Near-Field Fluorescence Microscopy of Dendritic Cells . . . . .	62
11.3.5	Chemical Information of Bacterial Surfaces and Detection of DNA Nucleobases by Tip-Enhanced Raman Spectroscopy . . . . .	64
11.4	Conclusions . . . . .	65
	References . . . . .	66
<b>12</b>	<b>Adhesion and Friction Properties of Polymers at Nanoscale: Investigation by AFM</b> <i>Sophie Bistac, Marjorie Schmitt</i> . . . . .	69
12.1	Introduction . . . . .	69
12.2	Experimental Part . . . . .	72
12.3	Nano-Adhesion Investigation . . . . .	73
12.4	Nano-Friction Investigation . . . . .	75
12.5	Relation Between Adhesion and Friction at Nanoscale . . . . .	78
12.6	Comparison with Macroscale Results . . . . .	79
	References . . . . .	83
<b>13</b>	<b>Mechanical Characterization of Materials by Micro-Indentation and AFM Scanning</b> <i>Gabriella Bolzon, Massimiliano Bocciarelli, Enzo J. Chiarullo</i> . . . . .	85
13.1	Introduction . . . . .	85

13.2	Experimental Techniques .....	89
13.2.1	Micro-Indentation .....	89
13.2.2	AFM Scanning .....	90
13.3	Inverse Analysis for Materials Characterization .....	94
13.3.1	Simulation of the Test .....	94
13.3.2	Optimization Procedures .....	100
13.4	Applications .....	102
13.4.1	On the Role of Friction .....	103
13.4.2	Tests Concerning HHM and DP Models .....	104
13.4.3	Anisotropic Materials .....	105
13.4.4	Self Stresses .....	109
13.4.5	Coatings and Layered Systems .....	110
	References .....	116

## **14 Mechanical Properties of Metallic Nanocontacts**

	<i>G. Rubio-Bollinger, J.J. Riquelme, S.Vieira, N. Agrait</i> .....	121
14.1	Introduction .....	122
14.2	Experimental Tools .....	123
14.2.1	The Scanning Tunneling Microscope Supplemented with a Force Sensor .....	125
14.2.2	The Mechanically Controllable Break-Junction Technique .....	126
14.3	Electron Transport Through Metallic Nanocontacts .....	128
14.4	Mechanical Properties of Metallic Nanocontacts .....	129
14.4.1	Fabrication of Metallic Nanocontacts .....	129
14.4.2	Elasticity and Fracture of Metallic Nanocontacts .....	131
14.4.3	The Shape of Metallic Nanocontacts .....	132
14.4.4	Inelastic Scattering by Phonons in Nanocontacts .....	134
14.5	Suspended Chains of Single Gold Atoms .....	135
14.5.1	Fabrication of Chains of Atoms Using Local Probes .....	136
14.5.2	Mechanical Processes During Formation of Atomic Chains .....	137
14.5.3	Phonons in Atomic Chains .....	140
14.6	Metallic Adhesion in Atomic-Sized Tunneling Junctions .....	144
	References .....	146

## **15 Dynamic AFM in Liquids: Viscous Damping and Applications to the Study of Confined Liquids**

	<i>Abdelhamid Maali, Touria Cohen-Bouhacina, Cedric Hurth, Cédric Jai, R. Boisgard, Jean-Pierre Aimé</i> .....	149
15.1	Introduction .....	149

15.2	Viscous Hydrodynamic Damping of the Cantilever in a Water Medium .....	150
15.3	Improving the Acoustic Excitation of the Cantilever-Tip .....	153
15.4	Theoretical Description of the Motion of an Acoustically Driven Cantilever in Liquid .....	155
15.5	Atomic Force Microscopy Study of the Molecular Ordering of a Confined Liquid .....	160
15.6	Conclusion .....	163
	References .....	163
<b>16</b>	<b>Microtensile Tests Using In Situ Atomic Force Microscopy</b> <i>Udo Lang, Jurg Dual</i> .....	165
16.1	Introduction .....	166
16.2	Literature Review .....	166
16.2.1	Organic Samples .....	166
16.2.2	Anorganic Samples .....	170
16.2.3	Summary .....	172
16.3	Recent Developments at the Center of Mechanics of ETH Zurich ...	172
16.3.1	Setup .....	172
16.3.2	Results .....	176
16.3.3	Outlook .....	179
16.4	Conclusions .....	180
	References .....	180
<b>17</b>	<b>Scanning Tunneling Microscopy of the Si(111)-7×7 Surface and Adsorbed Ge Nanostructures</b> <i>Haiming Guo, Yeliang Wang, Hongjun Gao</i> .....	183
17.1	Introduction .....	184
17.2	STM Imaging on Si(111)-7×7: Resolving the Rest Atoms .....	185
17.2.1	The Familiarity: Si(111)-7×7 Structure and STM .....	185
17.2.2	The Simultaneous Imaging of the Rest Atoms and Adatoms .....	187
17.2.3	Voltage-Dependent Imaging of Rest Atoms .....	188
17.2.4	First-Principles Calculations .....	191
17.3	Atomic Manipulation on Si(111)-7×7 Surfaces with STM .....	193
17.3.1	Introduction .....	193
17.3.2	Fabricating Groove Nanostructures on Si(111)-7×7 Surfaces .....	193
17.3.3	The Modification Mechanism .....	195
17.4	Ge Nanostructure Growth on Si(111)-7×7 Surfaces .....	197
17.4.1	Introduction .....	197



---

17.4.2	Experimental Aspects . . . . .	198
17.4.3	Initial Adsorption of Ge Atoms on the Si(111)- $7\times 7$ Surface . . . . .	198
17.4.4	Temperature Dependence of Formation and Arrangement of Ge Clusters . . . . .	205
17.4.5	Electronic Structures of Ge Clusters and Evolution of the Hexagonal Superlattice . . . . .	208
17.4.6	Formation of Ge Islands and Ge–Si Intermixing at High Temperature	212
17.5	Conclusions . . . . .	216
	References . . . . .	217
	<b>Subject Index</b> . . . . .	221



---

# Contents – Volume I

## Part I Scanning Probe Microscopy

<b>1</b>	<b>Dynamic Force Microscopy</b> <i>André Schirmeisen, Boris Anczykowski, Harald Fuchs . . . . .</i>	<b>3</b>
<b>2</b>	<b>Interfacial Force Microscopy: Selected Applications</b> <i>Jack E. Houston . . . . .</i>	<b>41</b>
<b>3</b>	<b>Atomic Force Microscopy with Lateral Modulation</b> <i>Volker Scherer, Michael Reinstädler, Walter Arnold . . . . .</i>	<b>75</b>
<b>4</b>	<b>Sensor Technology for Scanning Probe Microscopy</b> <i>Egbert Oesterschulze, Rainer Kassing . . . . .</i>	<b>117</b>
<b>5</b>	<b>Tip Characterization for Dimensional Nanometrology</b> <i>John S. Villarrubia . . . . .</i>	<b>147</b>

## Part II Characterization

<b>6</b>	<b>Micro/Nanotribology Studies Using Scanning Probe Microscopy</b> <i>Bharat Bhushan . . . . .</i>	<b>171</b>
<b>7</b>	<b>Visualization of Polymer Structures with Atomic Force Microscopy</b> <i>Sergei Magonov . . . . .</i>	<b>207</b>
<b>8</b>	<b>Displacement and Strain Field Measurements from SPM Images</b> <i>Jürgen Keller, Dietmar Vogel, Andreas Schubert, Bernd Michel . . . . .</i>	<b>253</b>
<b>9</b>	<b>AFM Characterization of Semiconductor Line Edge Roughness</b> <i>Ndubuisi G. Orji, Martha I. Sanchez, Jay Raja, Theodore V. Vorburger . . . . .</i>	<b>277</b>
<b>10</b>	<b>Mechanical Properties of Self-Assembled Organic Monolayers: Experimental Techniques and Modeling Approaches</b> <i>Redhouane Henda . . . . .</i>	<b>303</b>

<b>11</b>	<b>Micro-Nano Scale Thermal Imaging Using Scanning Probe Microscopy</b> <i>Li Shi, Arun Majumdar</i> . . . . .	327
<b>12</b>	<b>The Science of Beauty on a Small Scale. Nanotechnologies Applied to Cosmetic Science</b> <i>Gustavo Luengo, Frédéric Leroy</i> . . . . .	363

### **Part III Industrial Applications**

<b>13</b>	<b>SPM Manipulation and Modifications and Their Storage Applications</b> <i>Sumio Hosaka</i> . . . . .	389
<b>14</b>	<b>Super Density Optical Data Storage by Near-Field Optics</b> <i>Jun Tominaga</i> . . . . .	429
<b>15</b>	<b>Capacitance Storage Using a Ferroelectric Medium and a Scanning Capacitance Microscope (SCM)</b> <i>Ryoichi Yamamoto</i> . . . . .	439
<b>16</b>	<b>Room-Temperature Single-Electron Devices formed by AFM Nano-Oxidation Process</b> <i>Kazuhiko Matsumoto</i> . . . . .	459

---

## Contents – Volume II

<b>1</b>	<b>Higher Harmonics in Dynamic Atomic Force Microscopy</b> <i>Robert W. Stark, Martin Stark</i> . . . . .	<b>1</b>
<b>2</b>	<b>Atomic Force Acoustic Microscopy</b> <i>Ute Rabe</i> . . . . .	<b>37</b>
<b>3</b>	<b>Scanning Ion Conductance Microscopy</b> <i>Tilman E. Schäffer, Boris Anczykowski, Harald Fuchs</i> . . . . .	<b>91</b>
<b>4</b>	<b>Spin-Polarized Scanning Tunneling Microscopy</b> <i>Wulf Wulfhekel, Uta Schlickum, Jürgen Kirschner</i> . . . . .	<b>121</b>
<b>5</b>	<b>Dynamic Force Microscopy and Spectroscopy</b> <i>Ferry Kienberger, Hermann Gruber, Peter Hinterdorfer</i> . . . . .	<b>143</b>
<b>6</b>	<b>Sensor Technology for Scanning Probe Microscopy and New Applications</b> <i>Egbert Oesterschulze, Leon Abelman, Arnout van den Bos, Rainer Kassing, Nicole Lawrence, Gunther Wittstock, Christiane Ziegler</i> . . . . .	<b>165</b>
<b>7</b>	<b>Quantitative Nanomechanical Measurements in Biology</b> <i>Małgorzata Lekka, Andrzej J. Kulik</i> . . . . .	<b>205</b>
<b>8</b>	<b>Scanning Microdeformation Microscopy: Subsurface Imaging and Measurement of Elastic Constants at Mesoscopic Scale</b> <i>Pascal Vairac, Bernard Cretin</i> . . . . .	<b>241</b>
<b>9</b>	<b>Electrostatic Force and Force Gradient Microscopy: Principles, Points of Interest and Application to Characterisation of Semiconductor Materials and Devices</b> <i>Paul Girard, Alexander Nikolaevitch Titkov</i> . . . . .	<b>283</b>
<b>10</b>	<b>Polarization-Modulation Techniques in Near-Field Optical Microscopy for Imaging of Polarization Anisotropy in Photonic Nanostructures</b> <i>Pietro Giuseppe Gucciardi, Ruggero Micheletto, Yoichi Kawakami, Maria Allegrini</i> . . . . .	<b>321</b>

---

<b>11</b>	<b>Focused Ion Beam as a Scanning Probe: Methods and Applications</b>	
	<i>Vittoria Raffa, Piero Castrataro, Arianna Menciassi, Paolo Dario .</i>	361

---

## Contents – Volume III

12	<b>Atomic Force Microscopy in Nanomedicine</b> <i>Dessy Nikova, Tobias Lange, Hans Oberleithner, Hermann Schillers, Andreas Ebner, Peter Hinterdorfer</i> . . . . .	1
13	<b>Scanning Probe Microscopy: From Living Cells to the Subatomic Range</b> <i>Ille C. Gebeshuber, Manfred Drack, Friedrich Aumayr, Hannspeter Winter, Friedrich Franek</i> . . . . .	27
14	<b>Surface Characterization and Adhesion and Friction Properties of Hydrophobic Leaf Surfaces and Nanopatterned Polymers for Superhydrophobic Surfaces</b> <i>Zachary Burton, Bharat Bhushan</i> . . . . .	55
15	<b>Probing Macromolecular Dynamics and the Influence of Finite Size Effects</b> <i>Scott Sills, René M. Overney</i> . . . . .	83
16	<b>Investigation of Organic Supramolecules by Scanning Probe Microscopy in Ultra-High Vacuum</b> <i>Laurent Nony, Enrico Gnecco, Ernst Meyer</i> . . . . .	131
17	<b>One- and Two-Dimensional Systems: Scanning Tunneling Microscopy and Spectroscopy of Organic and Inorganic Structures</b> <i>Luca Gavioli, Massimo Sancrotti</i> . . . . .	183
18	<b>Scanning Probe Microscopy Applied to Ferroelectric Materials</b> <i>Oleg Tikhomirov, Massimiliano Labardi, Maria Allegrini</i> . . . . .	217
19	<b>Morphological and Tribological Characterization of Rough Surfaces by Atomic Force Microscopy</b> <i>Renato Buzio, Ugo Valbusa</i> . . . . .	261
20	<b>AFM Applications for Contact and Wear Simulation</b> <i>Nikolai K. Myshkin, Mark I. Petrokovets, Alexander V. Kovalev</i> . . . . .	299
21	<b>AFM Applications for Analysis of Fullerene-Like Nanoparticles</b> <i>Lev Rapoport, Armen Verdyan</i> . . . . .	327

---

<b>22</b>	<b>Scanning Probe Methods in the Magnetic Tape Industry</b>	
	<i>James K. Knudsen . . . . .</i>	343



---

## Contents – Volume IV

23	<b>Scanning Probe Lithography for Chemical, Biological and Engineering Applications</b> <i>Joseph M. Kinsella, Alben Ivanisevic . . . . .</i>	1
24	<b>Nanotribological Characterization of Human Hair and Skin Using Atomic Force Microscopy (AFM)</b> <i>Bharat Bhushan, Carmen LaTorre . . . . .</i>	35
25	<b>Nanofabrication with Self-Assembled Monolayers by Scanning Probe Lithography</b> <i>Jayne C. Garno, James D. Batteas . . . . .</i>	105
26	<b>Fabrication of Nanometer-Scale Structures by Local Oxidation Nanolithography</b> <i>Marta Tello, Fernando García, Ricardo García . . . . .</i>	137
27	<b>Template Effects of Molecular Assemblies Studied by Scanning Tunneling Microscopy (STM)</b> <i>Chen Wang, Chunli Bai . . . . .</i>	159
28	<b>Microfabricated Cantilever Array Sensors for (Bio-)Chemical Detection</b> <i>Hans Peter Lang, Martin Hegner, Christoph Gerber . . . . .</i>	183
29	<b>Nano-Thermomechanics: Fundamentals and Application in Data Storage Devices</b> <i>B. Gotsmann, U. Dürig . . . . .</i>	215
30	<b>Applications of Heated Atomic Force Microscope Cantilevers</b> <i>Brent A. Nelson, William P. King . . . . .</i>	251



---

## Contents – Volume V

<b>1</b>	<b>Integrated Cantilevers and Atomic Force Microscopes</b> <i>Sadik Hafizovic, Kay-Uwe Kirstein, Andreas Hierlemann . . . . .</i>	<b>1</b>
<b>2</b>	<b>Electrostatic Microscanner</b> <i>Yasuhisa Ando . . . . .</i>	<b>23</b>
<b>3</b>	<b>Low-Noise Methods for Optical Measurements of Cantilever Deflections</b> <i>Tilman E. Schäffer . . . . .</i>	<b>51</b>
<b>4</b>	<b>Q-controlled Dynamic Force Microscopy in Air and Liquids</b> <i>Hendrik Hölscher, Daniel Ebeling, Udo D. Schwarz . . . . .</i>	<b>75</b>
<b>5</b>	<b>High-Frequency Dynamic Force Microscopy</b> <i>Hideki Kawakatsu . . . . .</i>	<b>99</b>
<b>6</b>	<b>Torsional Resonance Microscopy and Its Applications</b> <i>Chanmin Su, Lin Huang, Craig B. Prater, Bharat Bhushan . . . . .</i>	<b>113</b>
<b>7</b>	<b>Modeling of Tip-Cantilever Dynamics in Atomic Force Microscopy</b> <i>Yaxin Song, Bharat Bhushan . . . . .</i>	<b>149</b>
<b>8</b>	<b>Combined Scanning Probe Techniques for In-Situ Electrochemical Imaging at a Nanoscale</b> <i>Justyna Wiedemair, Boris Mizaikoff, Christine Kranz . . . . .</i>	<b>225</b>
<b>9</b>	<b>New AFM Developments to Study Elasticity and Adhesion at the Nanoscale</b> <i>Robert Szożkiewicz, Elisa Riedo . . . . .</i>	<b>269</b>
<b>10</b>	<b>Near-Field Raman Spectroscopy and Imaging</b> <i>Pietro Giuseppe Gucciardi, Sebastiano Trusso, Cirino Vasi, Salvatore Patanè, Maria Allegrini . . . . .</i>	<b>287</b>



---

## Contents – Volume VI

<b>11</b>	<b>Scanning Tunneling Microscopy of Physisorbed Monolayers: From Self-Assembly to Molecular Devices</b>	
	<i>Thomas Müller</i> . . . . .	1
<b>12</b>	<b>Tunneling Electron Spectroscopy Towards Chemical Analysis of Single Molecules</b>	
	<i>Tadahiro Komeda</i> . . . . .	31
<b>13</b>	<b>STM Studies on Molecular Assembly at Solid/Liquid Interfaces</b>	
	<i>Ryo Yamada, Kohei Uosaki</i> . . . . .	65
<b>14</b>	<b>Single-Molecule Studies on Cells and Membranes Using the Atomic Force Microscope</b>	
	<i>Ferry Kienberger, Lilia A. Chitchevlova, Andreas Ebner, Theeraporn Puntheeranurak, Hermann J. Gruber, Peter Hinterdorfer</i> . . . . .	101
<b>15</b>	<b>Atomic Force Microscopy of DNA Structure and Interactions</b>	
	<i>Neil H. Thomson</i> . . . . .	127
<b>16</b>	<b>Direct Detection of Ligand–Protein Interaction Using AFM</b>	
	<i>Małgorzata Lekka, Piotr Laidler, Andrzej J. Kulik</i> . . . . .	165
<b>17</b>	<b>Dynamic Force Microscopy for Molecular-Scale Investigations of Organic Materials in Various Environments</b>	
	<i>Hirofumi Yamada, Kei Kobayashi</i> . . . . .	205
<b>18</b>	<b>Noncontact Atomic Force Microscopy</b>	
	<i>Yasuhiro Sugawara</i> . . . . .	247
<b>19</b>	<b>Tip-Enhanced Spectroscopy for Nano Investigation of Molecular Vibrations</b>	
	<i>Norihiko Hayazawa, Yuika Saito</i> . . . . .	257

---

<b>20</b>	<b>Investigating Individual Carbon Nanotube/Polymer Interfaces with Scanning Probe Microscopy</b>	
	<i>Asa H. Barber, H. Daniel Wagner, Sidney R. Cohen . . . . .</i>	<i>287</i>

---

## Contents – Volume VII

21	<b>Lotus Effect: Roughness-Induced Superhydrophobicity</b> <i>Michael Nosonovsky, Bharat Bhushan . . . . .</i>	1
22	<b>Gecko Feet: Natural Attachment Systems for Smart Adhesion</b> <i>Bharat Bhushan, Robert A. Sayer . . . . .</i>	41
23	<b>Novel AFM Nanoprobes</b> <i>Horacio D. Espinosa, Nicolaie Moldovan, K.-H. Kim . . . . .</i>	77
24	<b>Nanoelectromechanical Systems – Experiments and Modeling</b> <i>Horacio D. Espinosa, Changhong Ke . . . . .</i>	135
25	<b>Application of Atom-resolved Scanning Tunneling Microscopy in Catalysis Research</b> <i>Jeppe Vang Lauritsen, Ronny T. Vang, Flemming Besenbacher . . .</i>	197
26	<b>Nanostructuration and Nanoimaging of Biomolecules for Biosensors</b> <i>Claude Martelet, Nicole Jaffrezic-Renault, Yanxia Hou, Abdelhamid Errachid, François Bessueille . . . . .</i>	225
27	<b>Applications of Scanning Electrochemical Microscopy (SECM)</b> <i>Gunther Wittstock, Malte Burchardt, Sascha E. Pust . . . . .</i>	259
28	<b>Nanomechanical Characterization of Structural and Pressure-Sensitive Adhesives</b> <i>Martin Munz, Heinz Sturm . . . . .</i>	301
29	<b>Development of MOEMS Devices and Their Reliability Issues</b> <i>Bharat Bhushan, Huiwen Liu . . . . .</i>	349





---

## Contents – Volume VIII

<b>1</b>	<b>Background-Free Apertureless Near-Field Optical Imaging</b> <i>Pietro Giuseppe Gucciardi, Guillaume Bachelier, Stephan J. Stranick, Maria Allegrini . . . . .</i>	<b>1</b>
<b>2</b>	<b>Critical Dimension Atomic Force Microscopy for Sub-50-nm Microelectronics Technology Nodes</b> <i>Hao-Chih Liu, Gregory A. Dahlen, Jason R. Osborne . . . . .</i>	<b>31</b>
<b>3</b>	<b>Near Field Probes: From Optical Fibers to Optical Nanoantennas</b> <i>Eugenio Cefali, Salvatore Patanè, Salvatore Spadaro, Renato Gardelli, Matteo Albani, Maria Allegrini . . . . .</i>	<b>77</b>
<b>4</b>	<b>Carbon Nanotubes as SPM Tips: Mechanical Properties of Nanotube Tips and Imaging</b> <i>Sophie Marsaudon, Charlotte Bernard, Dirk Dietzel, Cattien V. Nguyen, Anne-Marie Bonnot, Jean-Pierre Aimé, Rodolphe Boisgard . . . . .</i>	<b>137</b>
<b>5</b>	<b>Scanning Probes for the Life Sciences</b> <i>Andrea M. Ho, Horacio D. Espinosa . . . . .</i>	<b>183</b>
<b>6</b>	<b>Self-Sensing Cantilever Sensor for Bioscience</b> <i>Hayato Sone, Sumio Hosaka . . . . .</i>	<b>219</b>
<b>7</b>	<b>AFM Sensors in Scanning Electron and Ion Microscopes: Tools for Nanomechanics, Nanoanalytics, and Nanofabrication</b> <i>Vinzenz Friedli, Samuel Hoffmann, Johann Michler, Ivo Utker . . . . .</i>	<b>247</b>
<b>8</b>	<b>Cantilever Spring-Constant Calibration in Atomic Force Microscopy</b> <i>Peter J. Cumpson, Charles A. Clifford, Jose F. Portoles, James E. Johnstone, Martin Munz . . . . .</i>	<b>289</b>
<b>9</b>	<b>Frequency Modulation Atomic Force Microscopy in Liquids</b> <i>Suzanne P. Jarvis, John E. Sader, Takeshi Fukuma . . . . .</i>	<b>315</b>

---

<b>10</b>	<b>Kelvin Probe Force Microscopy: Recent Advances and Applications</b> <i>Yossi Rosenwaks, Oren Tal, Shimon Saraf, Alex Schwarzman, Eli Lepkifker, Amir Boag . . . . .</i>	<b>351</b>
<b>11</b>	<b>Application of Scanning Capacitance Microscopy to Analysis at the Nanoscale</b> <i>Štefan Lányi . . . . .</i>	<b>377</b>
<b>12</b>	<b>Probing Electrical Transport Properties at the Nanoscale by Current-Sensing Atomic Force Microscopy</b> <i>Laura Fumagalli, Ignacio Casuso, Giorgio Ferrari, Gabriel Gomila . . . . .</i>	<b>421</b>

---

## Contents – Volume IX

13	<b>Ultrathin Fullerene-Based Films via STM and STS</b> <i>Luca Gavioli, Cinzia Cepek . . . . .</i>	1
14	<b>Quantitative Measurement of Materials Properties with the (Digital) Pulsed Force Mode</b> <i>Alexander M. Gigler, Othmar Marti . . . . .</i>	23
15	<b>Advances in SPMs for Investigation and Modification of Solid-Supported Monolayers</b> <i>Bruno Pignataro . . . . .</i>	55
16	<b>Atomic Force Microscopy Studies of the Mechanical Properties of Living Cells</b> <i>Félix Rico, Ewa P. Wojcikiewicz, Vincent T. Moy . . . . .</i>	89
17	<b>Towards a Nanoscale View of Microbial Surfaces Using the Atomic Force Microscope</b> <i>Claire Verbelen, Guillaume Andre, Xavier Haulot, Yann Gilbert, David Alsteens, Etienne Dague and Yves F. Dufrêne . . . . .</i>	111
18	<b>Cellular Physiology of Epithelium and Endothelium</b> <i>Christoph Riethmüller, Hans Oberleithner . . . . .</i>	127
19	<b>Application of Atomic Force Microscopy to the Study of Expressed Molecules in or on a Single Living Cell</b> <i>Hyonchol Kim, Hironori Uehara, Rehana Afrin, Hiroshi Sekiguchi, Hideo Arakawa, Toshiya Osada, Atsushi Ikai . . . . .</i>	149
20	<b>What Can Atomic Force Microscopy Say About Amyloid Aggregates?</b> <i>Amalisa Relini, Ornella Cavalleri, Claudio Canale, Tiziana Svaldo-Lanero, Ranieri Rolandi, Alessandra Gliozzi . . . . .</i>	177

21	<b>Atomic Force Microscopy: Interaction Forces Measured in Phospholipid Monolayers, Bilayers and Cell Membranes</b> <i>Zoya Leonenko, David Cramb, Matthias Amrein, Eric Finot . . . .</i>	207
22	<b>Self-Assembled Monolayers on Aluminum and Copper Oxide Surfaces: Surface and Interface Characteristics, Nanotribological Properties, and Chemical Stability</b> <i>E. Hoque, J. A. DeRose, B. Bhushan, H. J. Mathieu . . . . .</i>	235
23	<b>High Sliding Velocity Nanotribological Investigations of Materials for Nanotechnology Applications</b> <i>Nikhil S. Tambe, Bharat Bhushan . . . . .</i>	283
24	<b>Measurement of the Mechanical Properties of One-Dimensional Polymer Nanostructures by AFM</b> <i>Sung-Kyoung Kim, Haiwon Lee . . . . .</i>	311
25	<b>Evaluating Tribological Properties of Materials for Total Joint Replacements Using Scanning Probe Microscopy</b> <i>Sriram Sundararajan, Kanaga Karupppiah Kanaga Subramanian .</i>	329
26	<b>Near-Field Optical Spectroscopy of Single Quantum Constituents</b> <i>Toshiharu Saiki . . . . .</i>	351

---

## Contents – Volume X

27	<b>Gecko Feet: Natural Attachment Systems for Smart Adhesion— Mechanism, Modeling, and Development of Bio-Inspired Materials</b> <i>Bharat Bhushan, Robert A. Sayer</i> . . . . .	1
28	<b>Carrier Transport in Advanced Semiconductor Materials</b> <i>Filippo Giannazzo, Patrick Fiorenza, Vito Raineri</i> . . . . .	63
29	<b>Visualization of Fixed Charges Stored in Condensed Matter and Its Application to Memory Technology</b> <i>Yasuo Cho</i> . . . . .	105
30	<b>Applications of Scanning Probe Methods in Chemical Mechanical Planarization</b> <i>Toshi Kasai, Bharat Bhushan</i> . . . . .	131
31	<b>Scanning Probe Microscope Application for Single Molecules in a <math>\pi</math>-Conjugated Polymer Toward Molecular Devices Based on Polymer Chemistry</b> <i>Ken-ichi Shinohara</i> . . . . .	153
32	<b>Scanning Probe Microscopy on Polymer Solar Cells</b> <i>Joachim Loos, Alexander Alexeev</i> . . . . .	183
33	<b>Scanning Probe Anodization for Nanopatterning</b> <i>Hiroyuki Sugimura</i> . . . . .	217
34	<b>Tissue Engineering: Nanoscale Contacts in Cell Adhesion to Substrates</b> <i>Mario D’Acunto, Paolo Giusti, Franco Maria Montevecchi, Gianluca Ciardelli</i> . . . . .	257
35	<b>Scanning Probe Microscopy in Biological Research</b> <i>Tatsuo Ushiki, Kazushige Kawabata</i> . . . . .	285
36	<b>Novel Nanoindentation Techniques and Their Applications</b> <i>Jiping Ye</i> . . . . .	309

---

<b>37</b>	<b>Applications to Nano-Dispersion Macromolecule Material Evaluation in an Electrophotographic Printer</b>	
	<i>Yasushi Kadota . . . . .</i>	347
<b>38</b>	<b>Automated AFM as an Industrial Process Metrology Tool for Nanoelectronic Manufacturing</b>	
	<i>Tianming Bao, David Fong, Sean Hand . . . . .</i>	359

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